Notice of References Cited Application/Control No. 10/522,043 Examiner Sean E. Aeder Applicant(s)/Patent Under Reexamination LU ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

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	Α	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO 00/55175 A1	09-2000		Rosen et al	
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NON-PATENT DOCUMENTS

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